


<b>Search Notes</b> 	<b>Application/Control No.</b> 10583914	<b>Applicant(s)/Patent Under Reexamination</b> BIJKER ET AL.
	<b>Examiner</b> JAE LEE	<b>Art Unit</b> 2895

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SEARCH NOTES		
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EAST search: see attached search histories	04/21/2009	JML
EAST search: see attached search histories	09/03/2009	JML

INTERFERENCE SEARCH			
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